SUPPORTING INFORMATION

Transition metal inclusion in RhoZMOF material

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Fig. S1 SEM-EDS diagram for one crystal of Ni-exchanged RhoZMOF crystal. C, N, O, In and Ni can be determined in the sample. * corresponds to Au used to cover the crystals by sputtering methods in order to increase the conductivity of the surfaces and hence the resolution of images.



Fig. S2 SEM-EDS results for clean and covered surfaces in some Ni-exchanged RhoZMOF crystals. SEM image taken by BSE detector (a); Ni to In molar ratio calculated in the clean-surface (b); normalized composition of the covered (c) and clean (d) surface of the crystal, (in molar %), normalized by In content which remains constant in the crystals.